Search Notes							

Application/Control No.	Applicant(s)/Patent under Reexamination
10/519,409	IWATA ET AL.
Examiner	Art Unit

1724

Scott Bushey

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Class	Subclass	Date	Examiner
261	152,155, 156,16,17, 78.2,116	2/2/2007	CSB
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PGPub T	ext Search	2/2/2007	СЅВ		

SEARCH NO (INCLUDING SEARCE		')
	DATE	EXMR
Inventor Name Search and Text Search	2/2/2007	CSB